Notice of References Cited

Application/Control No. 09/707,963	Reexamination	Applicant(s)/Patent Under Reexamination TEZUKA, ASUMARU		
Examiner	Art Unit			
Duv K Le	2685	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,366,784	04-2002	Hsueh, Chih-Yuan	455/462
	В	US-6,466,799	10-2002	Torrey et al.	455/462
	C	US-6,314,298 '	11-2001	Hiroki, Shigeru	455/465
	D	US-6,643,523 •	11-2003	Goetz, Ian	455/557
	Е	US-4,752,949 ·	06-1988	Steinbeck et al.	455/74.1
	F	US-5,555,448	09-1996	Thiede et al.	455/74.1
	G	US-4,860,335	08-1989	Namekawa, Makoto	455/404.1
	Н	US-5,903,835 ·	05-1999	Dent, Paul W.	455/427
	ı	US-6,073,031 ·	06-2000	Helstab et al.	455/557
	J	US-6,314,303 ·	11-2001	Phipps, Alastair	455/555
	к	US-6,125,277	09-2000	Tanaka, Kiyoshi	455/436
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

NON-I ATENT DODOMENTO				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	w			
	х			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

